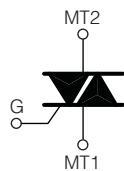
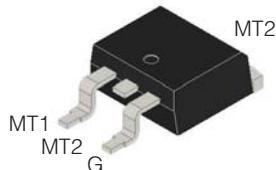


## LOGIC LEVEL TRIAC

### D<sup>2</sup>PAK


**On-State Current**

16 Amp

**Gate Trigger Current**

≤ 10 mA

**Off-State Voltage**

200 V ÷ 800 V

This series of TRIACs uses a high performance PNPN technology.

These parts are intended for general purpose AC switching applications with highly inductive loads.

### Absolute Maximum Ratings, according to IEC publication No. 134

SYMBOL	PARAMETER	CONDITIONS	Value	Unit
$I_{T(RMS)}$	RMS On-state Current (full sine wave)	All Conduction Angle, $T_C = 95^\circ C$	16	A
$I_{TSM}$	Non-repetitive On-State Current	Full Cycle, 60 Hz ( $t = 16.7 \text{ ms}$ )	176	A
$I_{TSM}$	Non-repetitive On-State Current	Full Cycle, 50 Hz ( $t = 20 \text{ ms}$ )	160	A
$I^2t$	Fusing Current	$t_p = 10 \text{ ms}$ , Half Cycle	128	$\text{A}^2\text{s}$
$I_{GM}$	Peak Gate Current	$20 \mu\text{s}$ max. $T_j = 125^\circ C$	4	A
$P_{G(AV)}$	Average Gate Power Dissipation	$T_j = 125^\circ C$	1	W
$dI/dt$	Critical rate of rise of on-state current	$I_G = 2x I_{GT}$ , $t_r \leq 100\text{ns}$ $f = 120 \text{ Hz}$ , $T_j = 125^\circ C$	50	$\text{A}/\mu\text{s}$
$T_j$	Operating Temperature		(-40 + 125)	°C
$T_{stg}$	Storage Temperature		(-40 + 150)	°C
$T_{sld}$	Soldering Temperature	10s max	260	°C

SYMBOL	PARAMETER	VOLTAGE					Unit
		B	D	M	S	N	
$V_{DRM}$	Repetitive Peak Off State Voltage	200	400	600	700	800	V
$V_{RRM}$							

## LOGIC LEVEL TRIAC

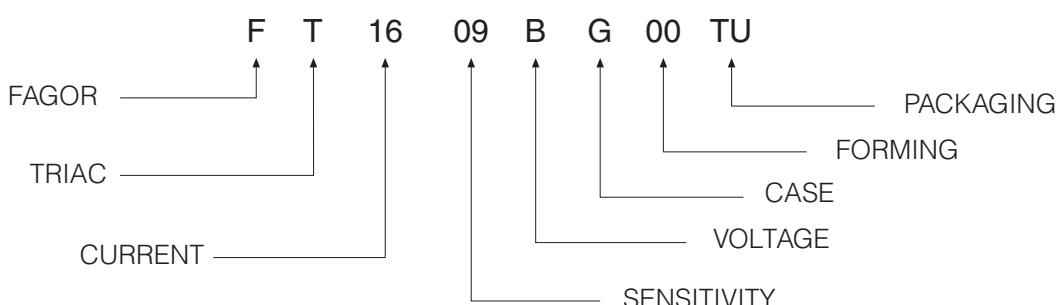
## Electrical Characteristics

SYMBOL	PARAMETER	CONDITIONS	Quadrant		SENSITIVITY		Unit
					09		
$I_{GT}^{(1)}$	Gate Trigger Current	$V_D = 12 \text{ V}_{DC}, R_L = 33 \Omega, T_j = 25^\circ C$	Q1÷Q3 Q4	MAX MAX	10	mA	mA
					10	mA	
$V_{GT}$	Gate Trigger Voltage	$V_D = 12 \text{ V}_{DC}, R_L = 33 \Omega, T_j = 25^\circ C$	Q1÷Q3 Q1÷Q4	MAX MAX	1.3	V	V
					1.3	V	
$V_{GD}$	Gate Non Trigger Voltage	$V_D = V_{DRM}, R_L = 3.3 \text{ K}\Omega, T_j = 125^\circ C$	Q1÷Q3 Q1÷Q4	MIN MIN	0.2	V	V
					0.2	V	
$I_H^{(2)}$	Holding Current	$I_T = 100 \text{ mA}, \text{Gate open}, T_j = 25^\circ C$		MAX	20	mA	
$I_L$	Latching Current	$I_G = 1.2 I_{GT}, T_j = 25^\circ C$	Q1,Q3 Q1,Q3,Q4 Q2	MAX MAX MAX		mA	mA
					20	mA	
					25	mA	
$dV/dt^{(2)}$	Critical Rate of Voltage Rise	$V_D = 0.67 \times V_{DRM}, \text{Gate open}$ $T_j = 125^\circ C$		MIN	40	V/ $\mu$ s	
$(dI/dt)c^{(2)}$	Critical Rate of Current Rise	$(dV/dt)c = 0.1 \text{ V}/\mu\text{s}$ $T_j = 125^\circ C$ $(dV/dt)c = 10 \text{ V}/\mu\text{s}$ $T_j = 125^\circ C$ without snubber $T_j = 125^\circ C$		MIN MIN MIN	2.5	A/ms	A/ms
					1.5	A/ms	
					-		
$V_{TM}^{(2)}$	On-state Voltage	$I_T = 22.5 \text{ Amp}, t_p = 380 \mu\text{s}, T_j = 25^\circ C$		MAX	1.60	V	
$V_{to}^{(2)}$	Threshold Voltage	$T_j = 125^\circ C$		MAX	0.77	V	
$r_d^{(2)}$	Dynamic resistance	$T_j = 125^\circ C$		MAX	50	$\text{m}\Omega$	
$I_{DRM}/I_{RRM}$	Off-State Leakage Current	$V_D = V_{DRM}, T_j = 125^\circ C$ $V_R = V_{RRM}, T_j = 25^\circ C$		MAX MAX	2	mA	$\mu\text{A}$
					5	$\mu\text{A}$	
$R_{th(j-c)}$	Thermal Resistance Junction-Case	for AC 360° conduction angle				1.1	$^\circ\text{C}/\text{W}$
$R_{th(j-a)}$	Thermal Resistance Junction-Ambient	$S = 1\text{cm}^2$				45	$^\circ\text{C}/\text{W}$

(1) Minimum  $I_{GT}$  is guaranteed at 5% of  $I_{GT}$  max.

(2) For either polarity of electrode MT2 voltage with reference to electrode MT1.

## PART NUMBER INFORMATION



## LOGIC LEVEL TRIAC

Fig. 1: Maximum power dissipation versus RMS on-state current (full cycle).

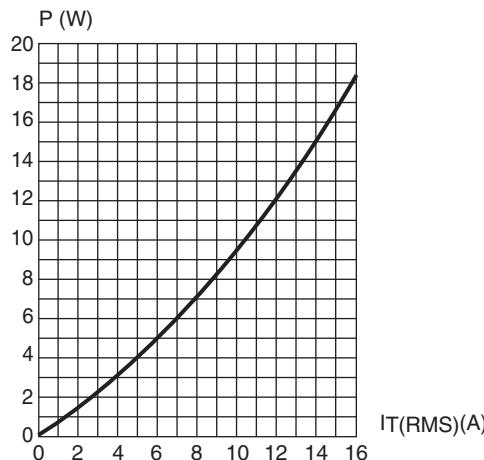


Fig. 2: RMS on-state current versus case temperature (full cycle).

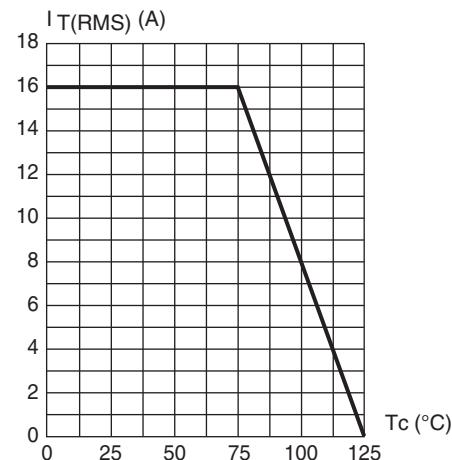


Fig. 3: Relative variation of thermal impedance versus pulse duration.

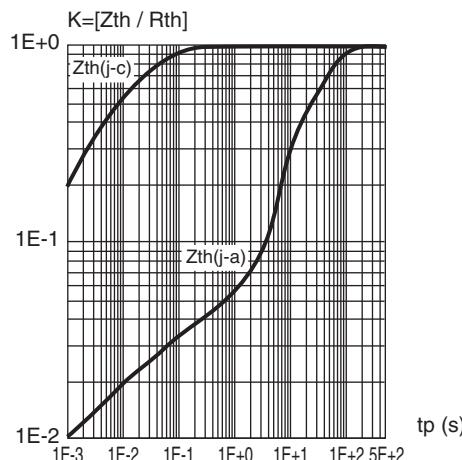


Fig. 5: Surge peak on-state current versus number of cycles

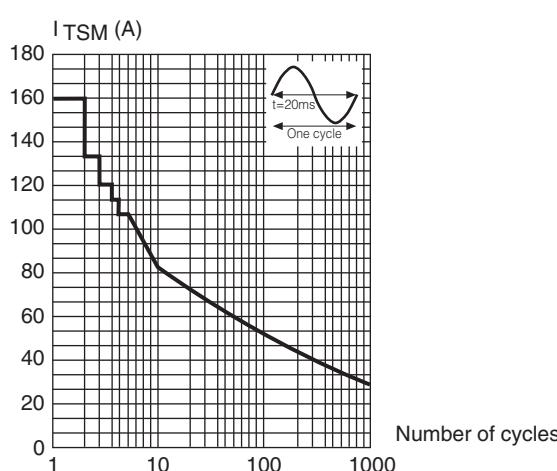


Fig. 4: On-state characteristics (maximum values)

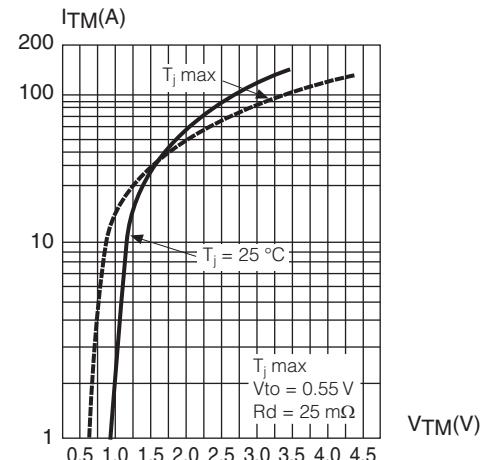
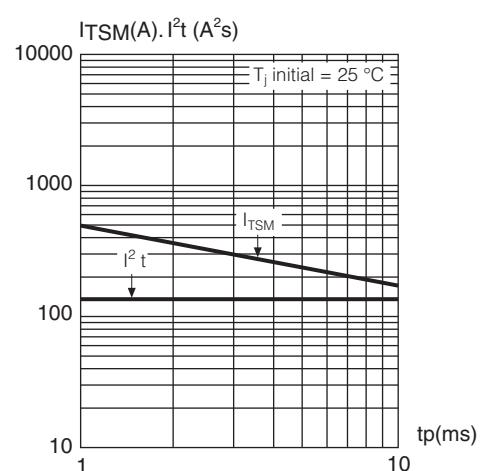


Fig. 6: Non-repetitive surge peak on-state current for a sinusoidal pulse with width tp<10ms, and corresponding value of I<sup>2</sup>t.



## LOGIC LEVEL TRIAC

Fig. 7: Relative variation of gate trigger current, holding current and latching versus junction temperature (typical values)

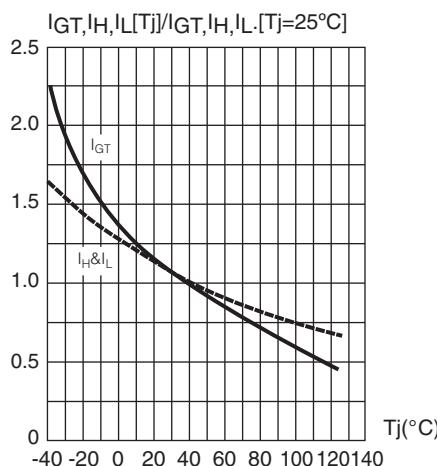


Fig. 8: Relative variation of critical rate of decrease of main current versus junction temperature

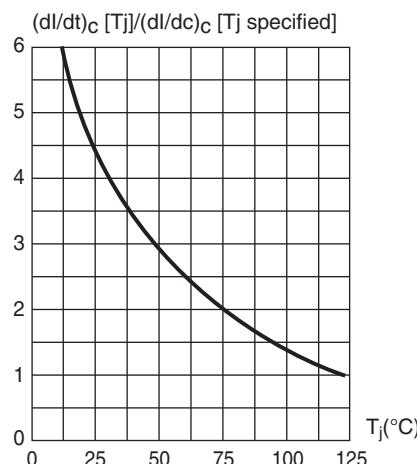
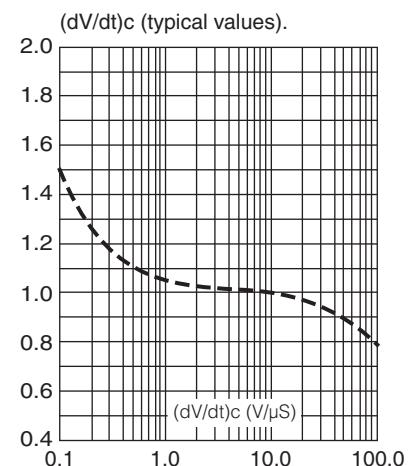
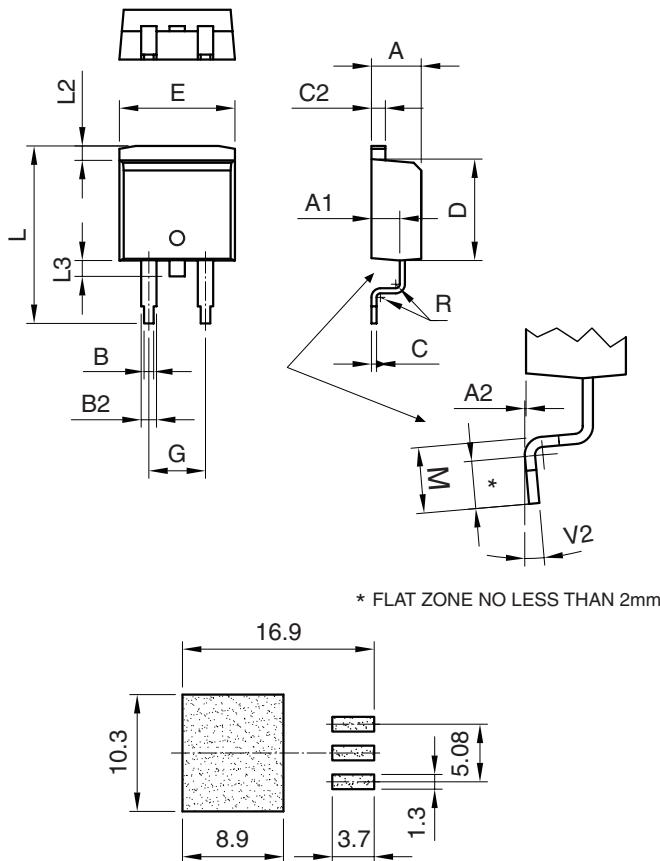


Fig. 9: Relative variation of critical rate of decrease of main current versus



### PACKAGE MECHANICAL DATA

### D<sup>2</sup>PAK



REF.	DIMENSIONS		
	Min.	Nominal	Max.
A	4.40	4.45	4.60
A1	2.49	2.50	2.69
A2	0.03	0.10	0.23
B	0.70	0.90	0.93
B2	1.14	1.03	1.70
C	0.45	0.45	0.60
C2	1.23	1.23	1.36
D	8.95	9.00	9.35
E	10.00	10.25	10.40
G	4.88	5.15	5.28
L	15.00	15.40	15.85
L2	1.27	1.27	1.40
L3	1.40	1.55	1.75
M	2.40	3.00	3.20
R	0.40 typ		
V2	0°		8°

NOTE: LIMITING VALUES AND LIFE SUPPORT APPLICATIONS (SEE WEB PAGE).